N-Channel 60 V (D-S) MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	$R_{DS(on)}$ (m Ω) (Typ.)	I _D (A) ^{a,e}	Q _g (Typ.)		
60	13 at $V_{GS} = 10 \text{ V}$	35	15.3 nC		
00	15.5 at V _{GS} = 4.5 V	30	13.3110		

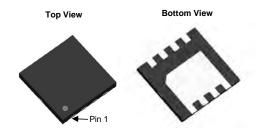
FEATURES

- **DT-Trench Power MOSFET**
- 100 % Rg and UIS Tested
- AEC-Q101 Qualified for **Automotive Applications**

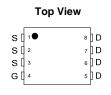


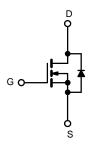
APPLICATIONS

- Notebook PC Core
- VRM/POL



DFN 3x3 EP





N-Channel MOSFET

Parameter		Symbol	Limit	Unit	
Drain-Source Voltage		V _{DS}	60	V	
Gate-Source Voltage		V _{GS}	± 20		
	T _C = 25 °C		35 ^{a, e}		
Continuous Drain Current (T _J = 175 °C)	T _C = 70 °C		32 ^e		
Continuous Diain Curient (1) = 175 C)	T _A = 25 °C	l _D	12 ^{b, c}	A	
	T _A = 70 °C		11 ^{b, c}		
Pulsed Drain Current		I _{DM}	110		
Avalanche Current Pulse	L = 0.1 mH	I _{AS}	26		
Single Pulse Avalanche Energy		E _{AS}	45	mJ	
Continuous Source-Drain Diode Current	T _C = 25 °C	I _S	35 ^{a, e}	А	
Continuous Source-Diam Diode Current	T _A = 25 °C	'S	30 ^{b, c}	^	
	T _C = 25 °C		30		
Mariana Barra Birahadia	T _C = 70 °C	P _D	19	\Box w	
Maximum Power Dissipation	T _A = 25 °C	' D	3.45 ^{b, c}	vv	
	T _A = 70 °C		2.3 ^{b, c}		
Operating Junction and Storage Temperature Ra	T _J , T _{stg}	- 55 to 175	°C		

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^{b, d}	t ≤ 10 s	R _{thJA}	33	43	°C/W	
Maximum Junction-to-Case	Steady State	R _{thJC}	3	5	10/00	

Notes:

- a. Based on T_C = 25 °C. b. Surface mounted on 1" x 1" FR4 board.
- c. t = 10 s.
- d. Maximum under steady state conditions is 90 °C/W. e. Calculated based on maximum junction temperature.



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Parameter	Symbol	Test Conditions	Min .	Тур.	Max.	Unit	
Static							
Drain-Source Breakdown Voltage	V_{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	60			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I _D = 250 μA		35		mV/°C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_{J}$	1D = 200 μΛ		- 5.5		IIIV/ C	
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	1.5		3	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA	
Zara Cata Valtaga Drain Current		$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}$	1 10		1		
Zero Gate Voltage Drain Current	I _{DSS}	$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 ^{\circ}\text{C}$			μA		
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	35			Α	
Drain-Source On-State Resistance ^a	D	$V_{GS} = 10 \text{ V}, I_D = 10 \text{ A}$		13	15	0	
	R _{DS(on)}	$V_{GS} = 4.5 \text{ V}, I_D = 8 \text{ A}$		15.5	20	mΩ	
Forward Transconductance ^a	9 _{fs}	V _{DS} = 15 V, I _D = 10 A		90		S	
Dynamic ^b				•	•		
Input Capacitance	C _{iss}			739		pF	
Output Capacitance	C _{oss}	V_{DS} = 30 V, V_{GS} = 0 V, f = 1 MHz		185			
Reverse Transfer Capacitance	C _{rss}			16			
Total Gate Charge	Qg			15.3		0	
Gate-Source Charge	Q _{gs}	$V_{DS} = 30 \text{ V}, V_{GS} = 10 \text{ V}, I_{D} = 10 \text{ A}$		1.5		nC	
Gate-Drain Charge	Q_{gd}			3.7			
Gate Resistance	R _g	f = 1 MHz		1.5		Ω	
Turn-On Delay Time	t _{d(on)}			6			
Rise Time	t _r	V_{DD} = 30 V, R_L = 1.5 Ω		2.8			
Turn-Off Delay Time	t _{d(off)}	$I_{D} = 10 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 3 \Omega$		19		ns	
Fall Time	t _f			3			
Drain-Source Body Diode Characteristic	s				<u> </u>	<u>'</u>	
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			35	А	
Pulse Diode Forward Current ^a	I _{SM}				110	^	
Body Diode Voltage	V _{SD}	I _S = 1 A		0.6	1.2	V	
Body Diode Reverse Recovery Time	t _{rr}			55	88	ns	
Body Diode Reverse Recovery Charge	Q _{rr}	I _F = 10 A, di/dt = 100 A/μs, T _{.I} = 25 °C		75	110	nC	
Reverse Recovery Fall Time	t _a	$I_F = 10 \text{ A}, \text{ al/at} = 100 \text{ A/}\mu\text{s}, I_J = 25 \text{ C}$		35		ns	
Reverse Recovery Rise Time	t _b			30			

Notes:

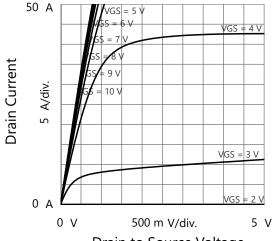
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle $\leq 2~\%.$

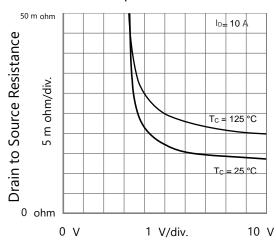
b. Guaranteed by design, not subject to production testing.



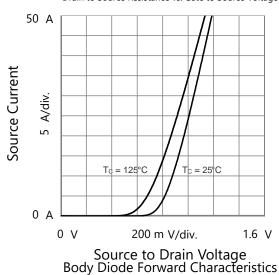
TYPICAL CHARACTERISTICS (T_A = 25 °C, unless otherwise noted)

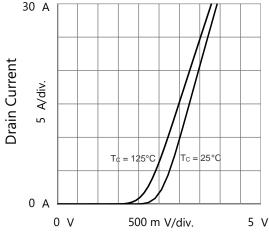


Drain to Source Voltage Output Characteristics

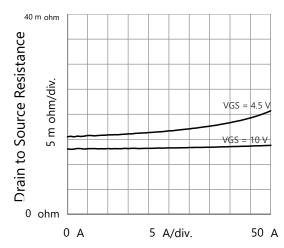


Gate to Source Voltage
Drain to Source Resistance vs. Gate to Source Voltage

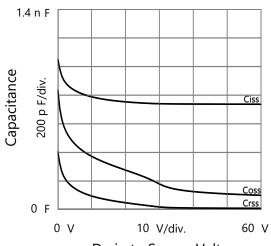




Gate to Source Voltage Transfer Characteristics



Drain Current
Drain to Source Resistance vs. Drain Current

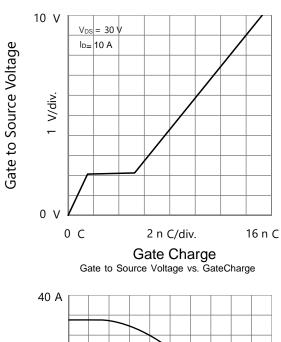


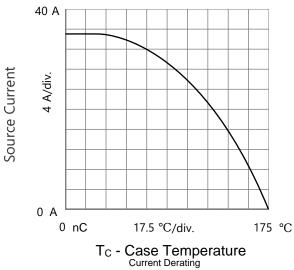
Drain to Source Voltage Capacitances

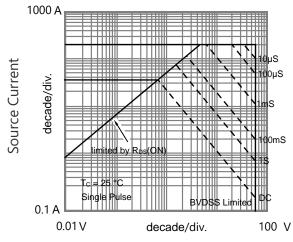


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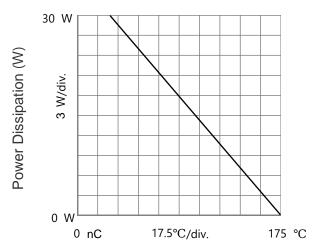




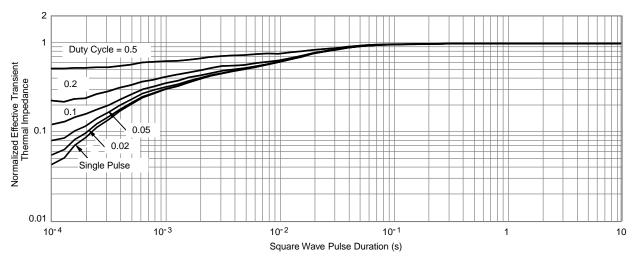








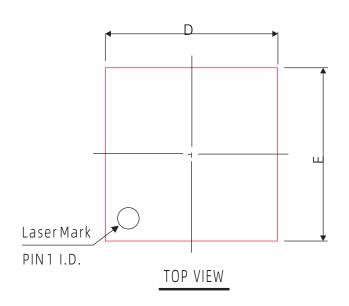
 $T_C \textbf{ - Case Temperature}_{\text{Current Derating}}$

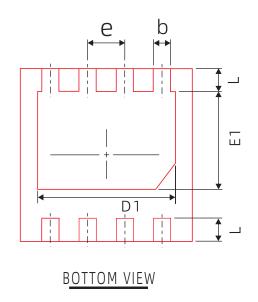


Normalized Thermal Transient Impedance, Junction-to-Case



DFN3*3-8L-A PACKAGE OUTLINE







COMMON DIMENSIONS (UNITS OF MEASURE=mm)

SYMBOL	MIN	NOM	MAX	
Α	0. 70	0.75	0.80	
A1	0. 00	0. 02	0. 05	
b	0. 25	0. 30	0. 35	
D	2. 95	3. 00	3. 07	
E	2. 95	3. 00	3. 07	
D1	2. 30	2. 40	2. 50	
E1	1.60	1. 70	1.80	
L	0. 30	0. 40	0. 50	
C	0. 203 REF			
е	0. 65 BSC			

OTHER DIMENSIONS

Α	0. 55	0.60	0. 65
Α	0. 50	0. 55	0.60



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